

<b>Notice of References Cited</b>	Application/Control No. 10/500,451	Applicant(s)/Patent Under Reexamination HAYASHI ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
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	C	US-			
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**FOREIGN PATENT DOCUMENTS**

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	N	JP 06116266 A	04-1994	Japan	SUGIMURA et al.	
	O					
	P					
	Q					
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Translation of JP 06116266 A
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